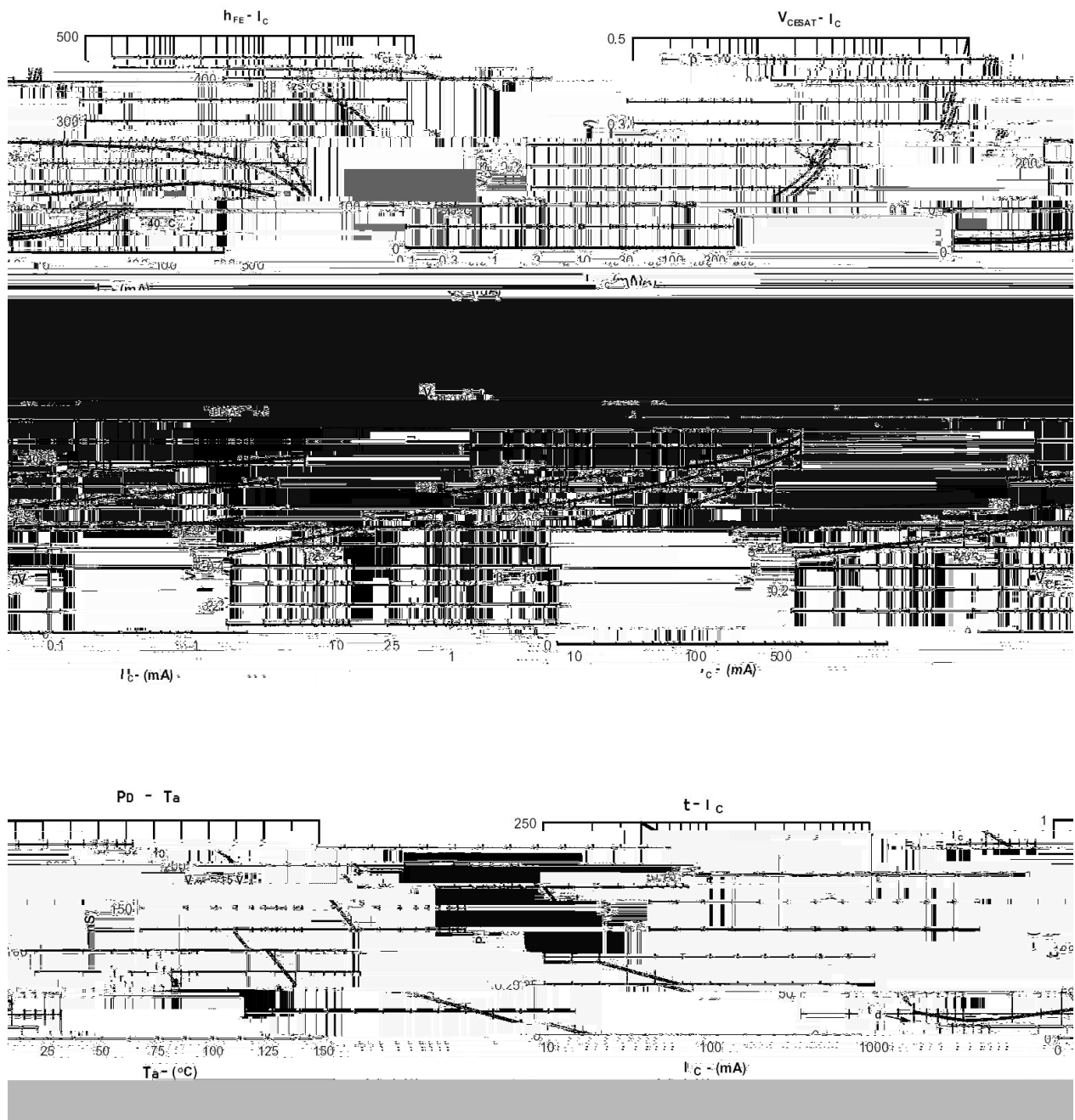


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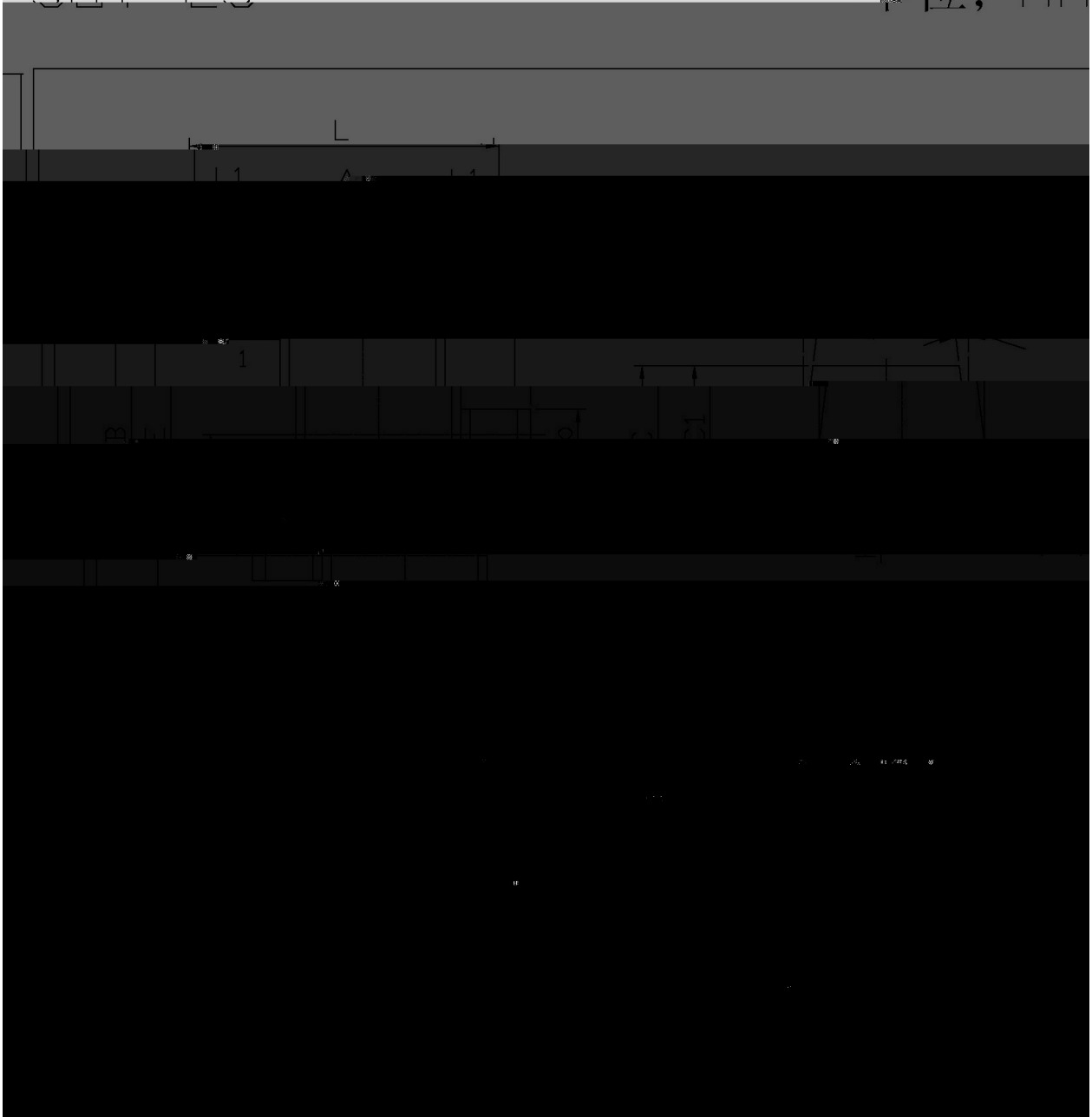
Parameter	Symbol	Rating	Unit
Collector to Base Voltage	$V_{CBO}$	-40	V
Collector to Emitter Voltage	$V_{CEO}$	-40	V
Emitter to Base Voltage	$V_{EBO}$	-5.0	V
Collector Current	$I_C$	-600	mA
Collector Power Dissipation	$P_C$	350	mW
Junction Temperature	$T_j$	150	
Storage Temperature Range	$T_{stg}$	-55 150	

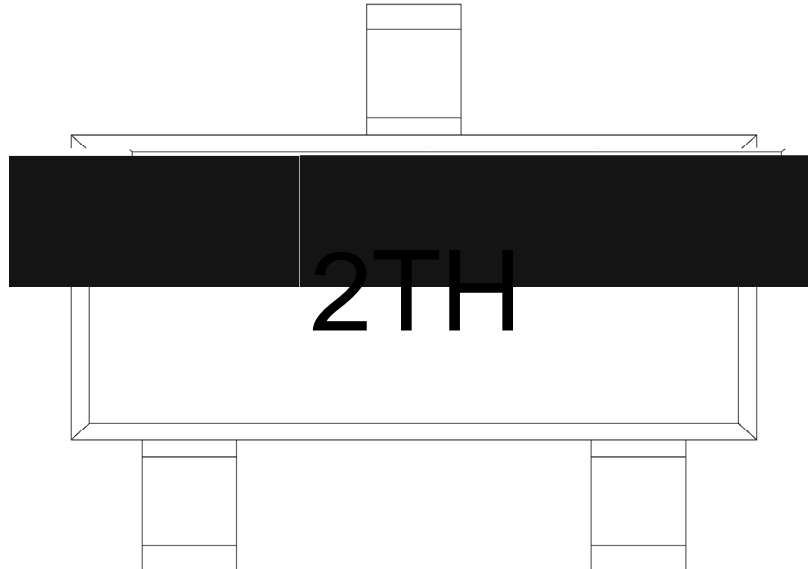
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector to Base Breakdown Voltage	$V_{CBO}$	$I_C=-0.1mA$ $I_E=0$	-40			V
Collector to Emitter Breakdown Voltage	$V_{CEO}$	$I_C=-1.0mA$ $I_B=0$	-40			V
Emitter to Base Breakdown Voltage	$V_{EBO}$	$I_E=-0.1mA$ $I_C=0$	-5.0			V
Collector Cut-Off Current	$I_{CBO}$	$V_{CB}=-40V$ $I_E=0$			-50	nA
Emitter Cut-Off Current	$I_{EBO}$	$V_{EB}=-5.0V$ $I_C=0$			-50	nA
DC Current Gain	$h_{FE(1)}$	$V_{CE}=-2.0V$ $I_C=-150mA$	100		300	
	$h_{FE(2)}$	$V_{CE}=-1.0V$ $I_C=-0.1mA$	30			
	$h_{FE(3)}$	$V_{CE}=-1.0V$ $I_C=-1.0mA$	60			
	$h_{FE(4)}$	$V_{CE}=-1.0V$ $I_C=-10mA$	100			
	$h_{FE(5)}$	$V_{CE}=-2.0V$ $I_C=-500mA$	20			
Collector-Emitter Saturation voltage	$V_{CE(sat)(1)}$	$I_C=-150mA$ $I_B=-15mA$			-0.4	V
	$V_{CE(sat)(2)}$	$I_C=-500mA$ $I_B=-50mA$			-0.75	V
Base-Emitter Saturation Voltage	$V_{BE(sat)(1)}$	$I_C=-150mA$ $I_B=-15mA$	-0.75		-0.95	V
	$V_{BE(sat)(2)}$	$I_C=-500mA$ $I_B=-50mA$			-1.3	V
Transition Frequency	$f_T$	$V_{CE}=-10V$ $I_C=-20mA$ $f=100MHz$	200			MHz
Delay Time	$t_d$	$V_{CC}=-30V$ $I_C=-150mA$ $I_{B1}=-15mA$			15	ns
Rise Time	$t_r$				20	ns
Storage Time	$t_s$	$V_{CC}=-30V$ $I_C=-150mA$ $I_{B1}=I_{B2}=-15mA$			225	ns
Fall Time	$t_f$				30	ns



SIU-23

单位: mm





2T

H

Note:

2T      Product Type Code

H        Company Code

